

N AND P-CHANNEL ENHANCEMENT MODE POWER MOSFET

N-CH BV _{DSS}	20V
RDS(ON)	75mΩ
I _D	3.5A
P-CH BV _{DSS}	-20V
RDS(ON)	160mΩ
I _D	-2.5A

Description

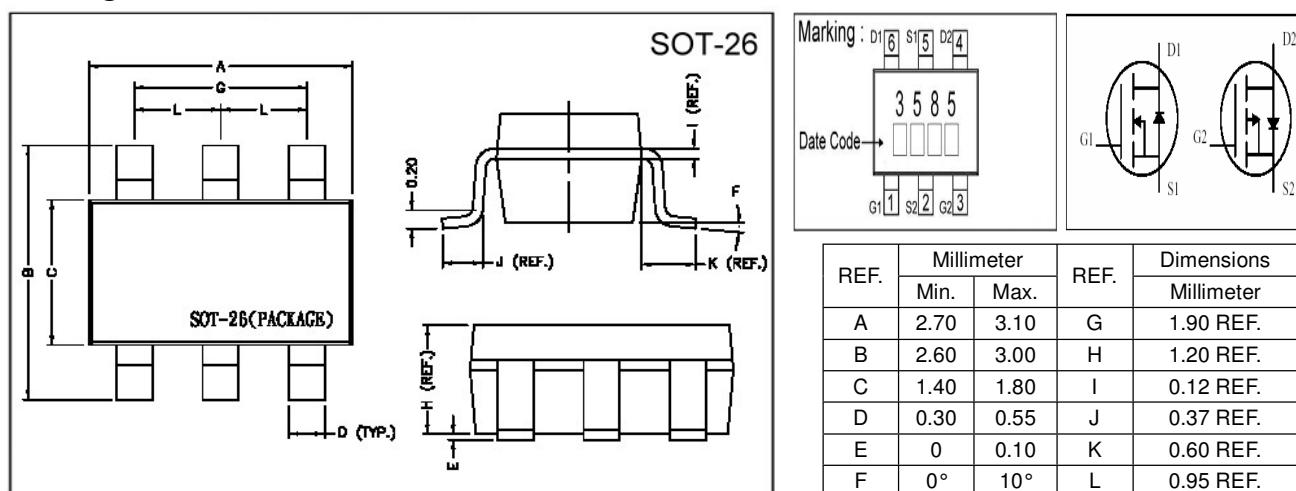
The BP358S provide the designer with best combination of fast switching, low on-resistance and cost-effectiveness.

The SOT-26 package is universally used for all commercial-industrial surface mount applications.

Features

- *Low Gate Change
- *Low On-resistance
- *RoHS Compliant

Package Dimensions



Absolute Maximum Ratings

Parameter	Symbol	Ratings		Unit
		N-channel	P-channel	
Drain-Source Voltage	V _{DS}	20	-20	V
Gate-Source Voltage	V _{GS}	± 12	± 12	V
Continuous Drain Current ³	I _D @ T _A =25°C	3.5	-2.5	A
Continuous Drain Current ³	I _D @ T _A =70°C	2.8	-1.97	A
Pulsed Drain Current ¹	I _{DM}	10	-10	A
Total Power Dissipation	P _D @ T _A =25°C	1.14		W
Linear Derating Factor		0.01		W/°C
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 ~ +150		°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient ³ Max.	R _{thj-a}	110	°C/W

N-Channel Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	20	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	0.02	-	$\text{V}/^\circ\text{C}$	Reference to 25°C , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	0.5	-	1.2	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$
Forward Transconductance	g_{fs}	-	7	-	S	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=3\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 12\text{V}$
Drain-Source Leakage Current($T_j=25^\circ\text{C}$)	I_{DSS}	-	-	1	μA	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source Leakage Current($T_j=70^\circ\text{C}$)		-	-	10	μA	$\text{V}_{\text{DS}}=16\text{V}, \text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance ²	$\text{R}_{\text{DS}(\text{ON})}$	-	-	75	m	$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=3.5\text{A}$
		-	-	125		$\text{V}_{\text{GS}}=2.5\text{V}, \text{I}_D=1.2\text{A}$
Total Gate Charge ²	Q_g	-	4	7	nC	$\text{I}_D=3\text{A}$ $\text{V}_{\text{DS}}=16\text{V}$ $\text{V}_{\text{GS}}=4.5\text{V}$
Gate-Source Charge	Q_{gs}	-	0.7	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	2	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	6	-	ns	$\text{V}_{\text{DS}}=15\text{V}$ $\text{I}_D=1\text{A}$ $\text{V}_{\text{GS}}=5\text{V}$ $\text{R}_G=3.3$ $\text{R}_D=15$
Rise Time	T_r	-	8	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	10	-		
Fall Time	T_f	-	3	-		
Input Capacitance	C_{iss}	-	230	370	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=20\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	55	-		
Reverse Transfer Capacitance	C_{rss}	-	40	-		
Gate Resistance	R_g	-	1.1	1.7		$f=1.0\text{MHz}$

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V_{SD}	-	-	1.2	V	$\text{I}_S=1.2\text{A}, \text{V}_{\text{GS}}=0\text{V}$
Reverse Recovery Time	T_{rr}	-	16	-	ns	$\text{I}_S=3\text{A}, \text{V}_{\text{GS}}=0\text{V}$ $d\text{I}/dt=100\text{A}/\mu\text{s}$
Reverse Recovery Charge	Q_{rr}	-	8	-	nC	

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

3. Surface mounted on 1 in² copper pad of FR4 board, $t \leq 5\text{sec}$; $180^\circ\text{C}/\text{W}$ when mounted on Min. copper pad.

P-Channel Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	-20	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=-250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	-0.01	-	$\text{V}/^\circ\text{C}$	Reference to 25°C , $\text{I}_D=-1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	-	-	-1.2	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$
Forward Transconductance	g_{fs}	-	4.0	-	S	$\text{V}_{\text{DS}}=-5\text{V}, \text{I}_D=-2\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 12\text{V}$
Drain-Source Leakage Current($T_j=25^\circ\text{C}$)	I_{DSS}	-	-	-1	uA	$\text{V}_{\text{DS}}=-20\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source Leakage Current($T_j=70^\circ\text{C}$)		-	-	-25	uA	$\text{V}_{\text{DS}}=-16\text{V}, \text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance ²	$\text{R}_{\text{DS}(\text{ON})}$	-	-	120	m	$\text{V}_{\text{GS}}=-10\text{V}, \text{I}_D=-2.8\text{A}$
		-	-	160		$\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_D=-2.5\text{A}$
		-	-	300		$\text{V}_{\text{GS}}=-2.5\text{V}, \text{I}_D=-2\text{A}$
Total Gate Charge ²	Q_g	-	5	8	nC	$\text{I}_D=-2\text{A}$ $\text{V}_{\text{DS}}=-16\text{V}$ $\text{V}_{\text{GS}}=-4.5\text{V}$
Gate-Source Charge	Q_{gs}	-	1	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	2	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	6	-	ns	$\text{V}_{\text{DS}}=-10\text{V}$ $\text{I}_D=-1\text{A}$ $\text{V}_{\text{GS}}=-10\text{V}$ $\text{R}_G=3.3$ $\text{R}_D=10$
Rise Time	T_r	-	17	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	16	-		
Fall Time	T_f	-	5	-		
Input Capacitance	C_{iss}	-	270	430	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=-20\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	70	-		
Reverse Transfer Capacitance	C_{rss}	-	55	-		

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V_{SD}	-	-	-1.2	V	$\text{I}_S=-1.2\text{A}, \text{V}_{\text{GS}}=0\text{V}$
Reverse Recovery Time ²	T_{rr}	-	20	-	ns	$\text{I}_S=-2\text{A}, \text{V}_{\text{GS}}=0\text{V}$ $d\text{I}/dt=100\text{A}/\mu\text{s}$
Reverse Recovery Charge	Q_{rr}	-	15	-	nC	

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

3. Surface mounted on 1 in² copper pad of FR4 board, $t \leq 5\text{sec}$; $180^\circ\text{C}/\text{W}$ when mounted on Min. copper pad.

Characteristics Curve N-Channel

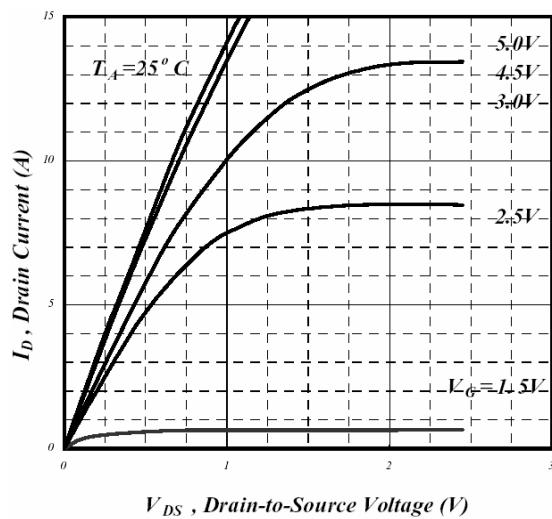


Fig 1. Typical Output Characteristics

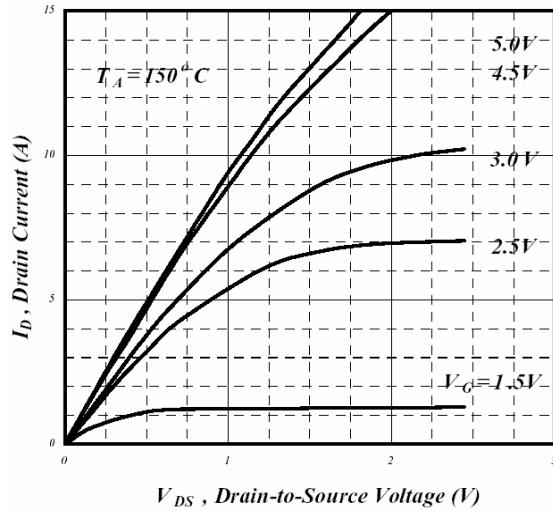


Fig 2. Typical Output Characteristics

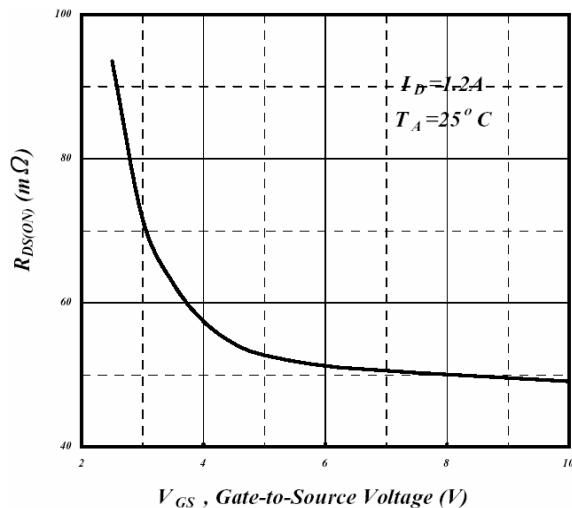


Fig 3. On-Resistance v.s. Gate Voltage

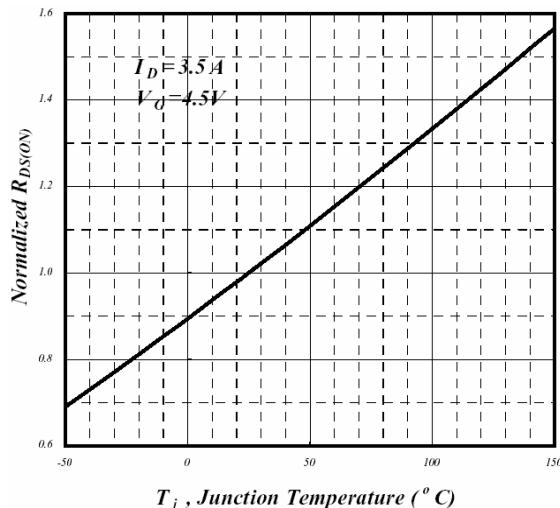


Fig 4. Normalized On-Resistance v.s. Junction Temperature

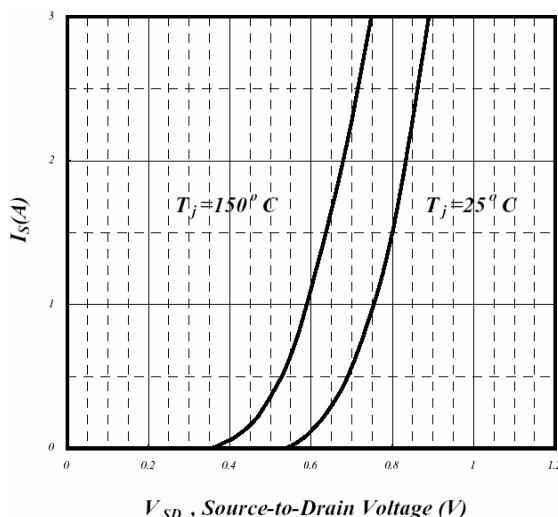


Fig 5. Forward Characteristics of Reverse Diode

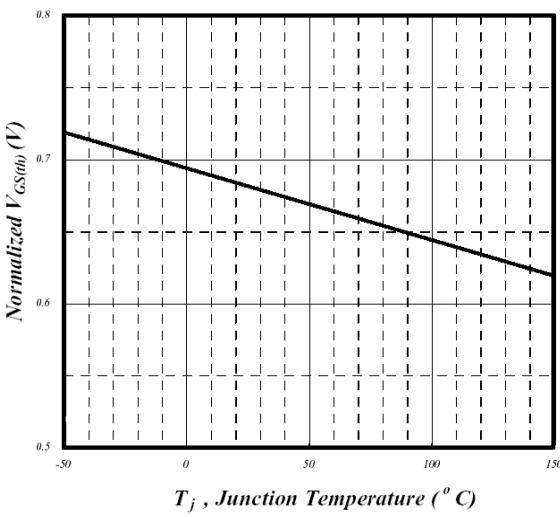


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

N-Channel

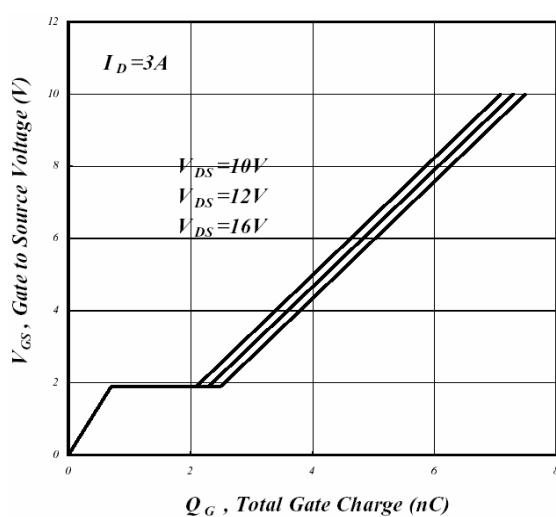


Fig 7. Gate Charge Characteristics

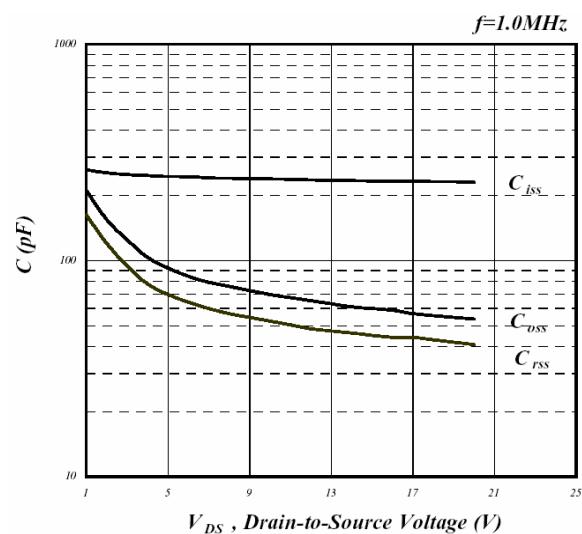


Fig 8. Typical Capacitance Characteristics

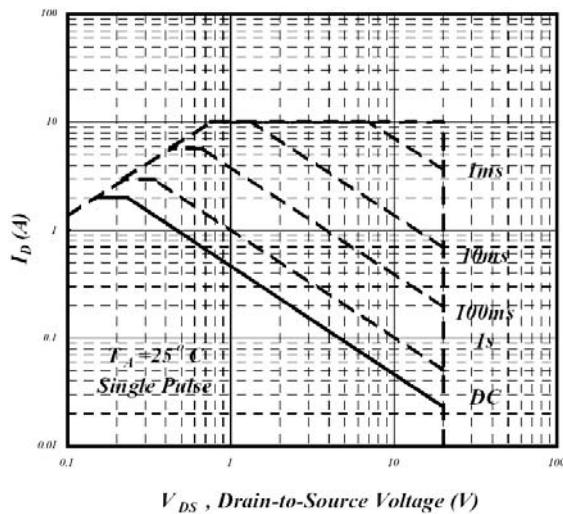


Fig 9. Maximum Safe Operating Area

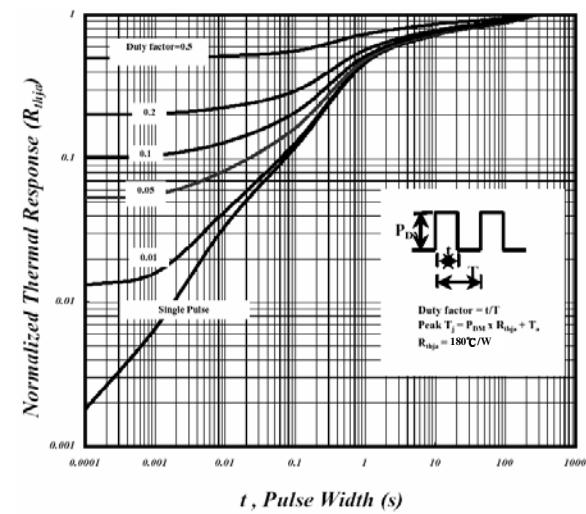


Fig 10. Effective Transient Thermal Impedance

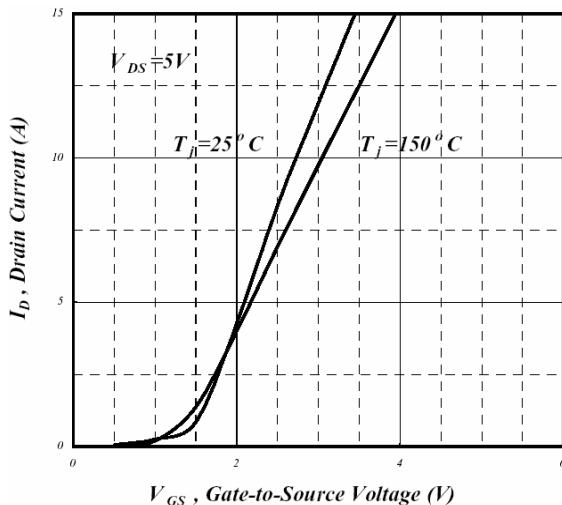


Fig 11. Transfer Characteristics

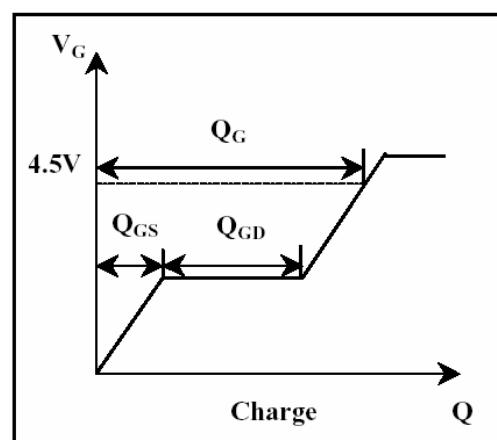


Fig 12. Gate Charge Waveform

P Channel

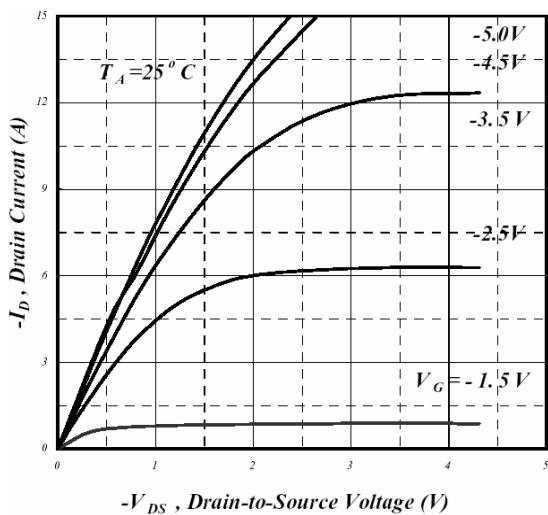


Fig 1. Typical Output Characteristics

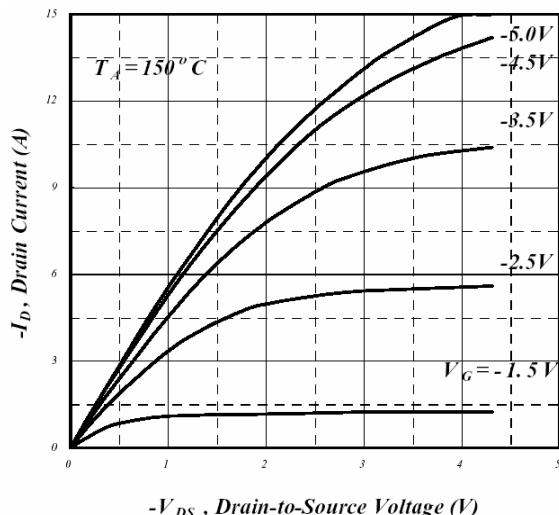


Fig 2. Typical Output Characteristics

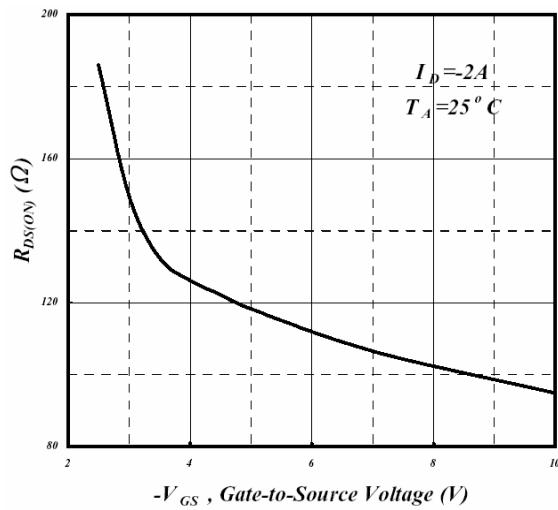


Fig 3. On-Resistance v.s. Gate Voltage

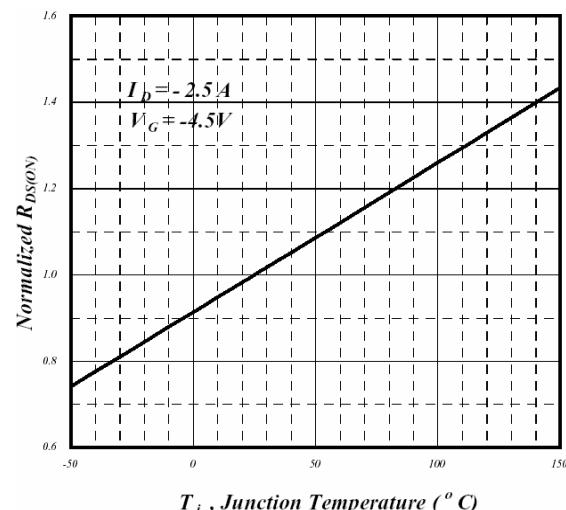


Fig 4. Normalized On-Resistance v.s. Junction Temperature

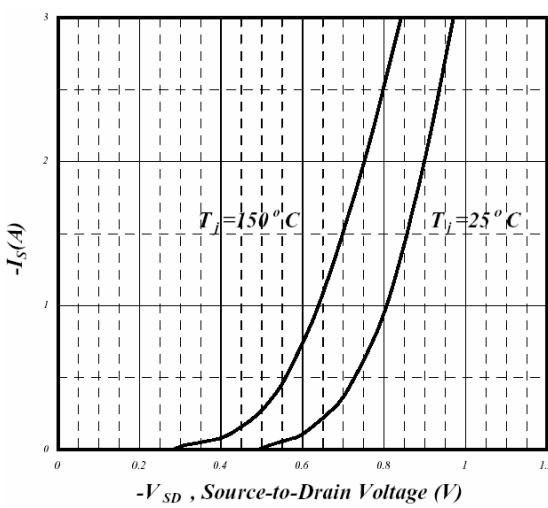


Fig 5. Forward Characteristics of Reverse Diode

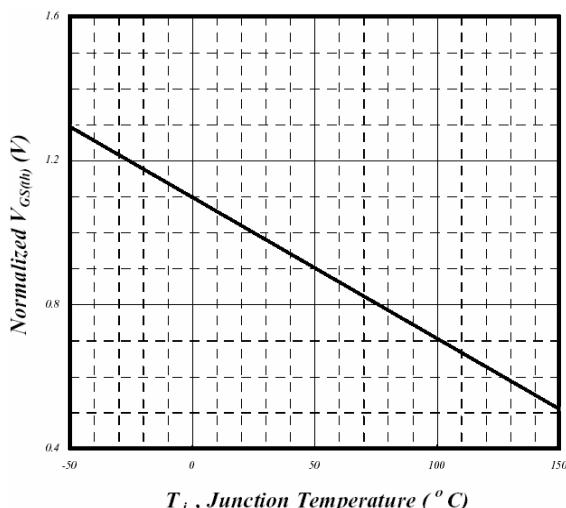


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

P-Channel

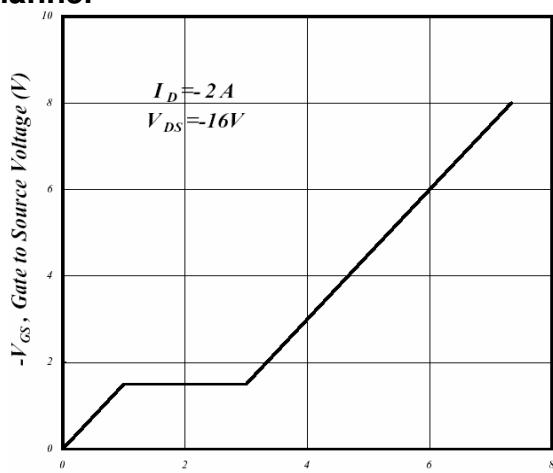


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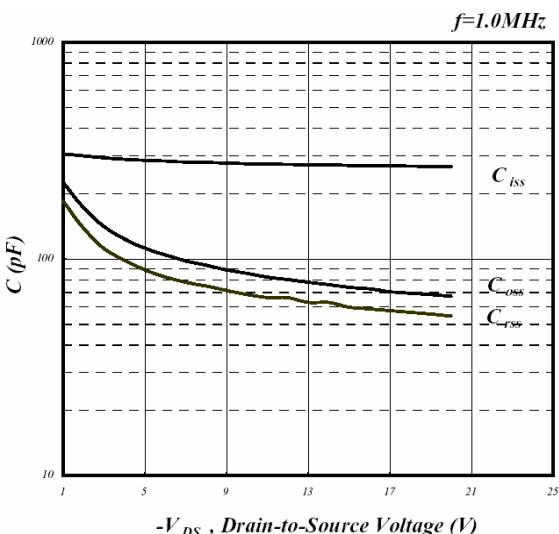


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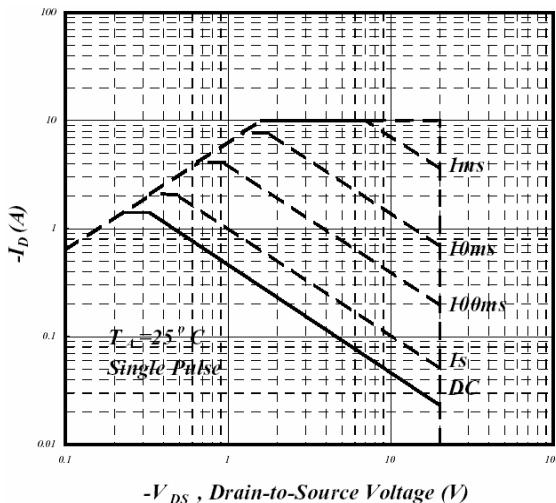


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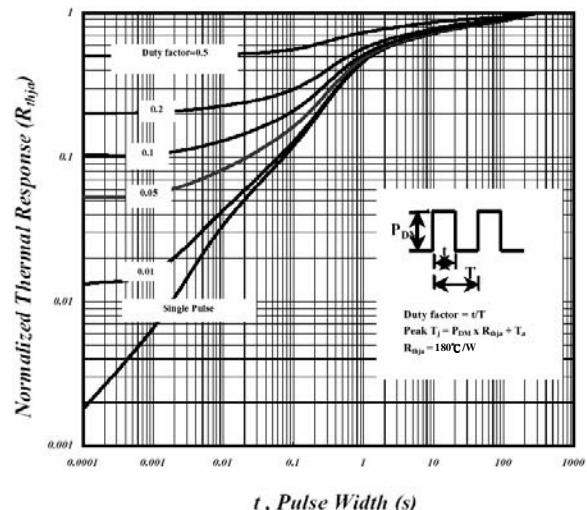


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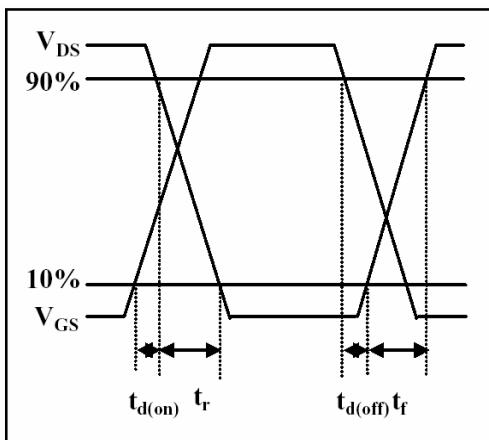


Fig 11. Switching Time Waveform

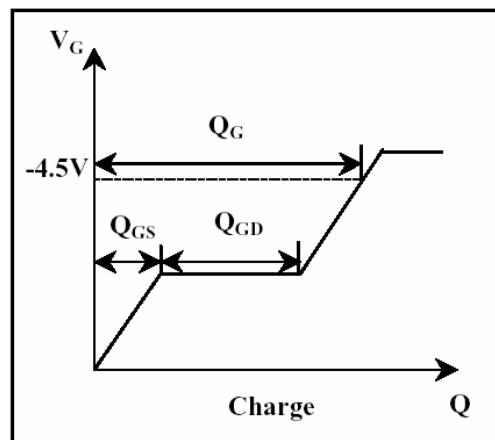


Fig 12. Gate Charge Waveform